## Pixelated liquid perovskite array for high-sensitivity and high-resolution X-ray imaging scintillation screens

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Figure S1 Cross-sectional image of the pixelated CsPbBr<sub>3</sub>/PPO liquid scintillator arrays



**Figure S2** (a) Photograph of the PPO powder. (b) RL spectra of PPO powder. Inset is the image of PPO under X-ray irradiation.



**Figure S3** Energy level alignment for the proposed mechanism of enhanced RL in the CsPbBr<sub>3</sub> QDs/PPO scintillator.



**Figure S4** (a) PL spectrum of CsPbBr<sub>3</sub> QDs/PPO LSS in ambient atmosphere. (b) PL peak intensity and FWHM of CsPbBr<sub>3</sub> QDs/PPO LSS extracted from (a). (c) PL peak position of CsPbBr<sub>3</sub> QDs/PPO LSS extracted from a).



Figure S5 X-ray imaging optical system.



Figure S6. X-ray imaging of the standard line-pair card by the pixelated CsPbBr<sub>3</sub>/PPO LSS.



Figure S7. Modulation transfer function (MTF) of CsPbBr<sub>3</sub> QDs/PPO LSS



Figure S8 TEM image and particle size distribution of the Mn:CsPbCl<sub>3</sub> QDs



Figure S9 (a-b)X-ray image of CsPbCl<sub>3</sub> QDs and Mn: CsPbCl<sub>3</sub> QDs under X-ray irradiation with different dose rate, respectively. (c) RL spectra of CsPbCl<sub>3</sub> QDs and Mn: CsPbCl<sub>3</sub> QDs.



**Figure S10** (a) PL spectrum of Mn: CsPbCl<sub>3</sub> QDs/PPO LSS in ambient atmosphere. (b) PL peak intensity and FWHM of Mn: CsPbCl<sub>3</sub> QDs/PPO LSS extracted from (a). (c) PL peak position of Mn: CsPbCl<sub>3</sub> QDs/PPO LSS extracted from (a).



Figure S11. X-ray images and photographs of circuit board, ball-point pen and leadwire using Mn: CsPbCl<sub>3</sub> QDs/PPO LSS.



**Figure S12** X-ray imaging of the standard line-pair card by the pixelated Mn: CsPbCl<sub>3</sub>/PPO LSS.



Figure S13. MTF of Mn:CsPbCl<sub>3</sub> QDs/PPO LSS



**Figure S14.** (a-b) Optical image of the pixelated CsPbBr<sub>3</sub>/PPO and Mn:CsPbCl<sub>3</sub> QDs/PPO liquid scintillator arrays under UV light excitation after the repeated filling/packaging process, respectively.



Figure S15. RL spectra of standard liquid scintillator (PPO+POPOP+toluene), CsPbBr<sub>3</sub>(60 mg/ml), CsPbBr<sub>3</sub>(60 mg/ml)+PPO (30 mg/ml) and CsPbBr<sub>3</sub>(60 mg/ml)+PPO (60 mg/ml), measured at 90 kV, 89 uA



Figure S16 RL spectra of CsPbBr<sub>3</sub> QDs/PPO LSS with 2 mm and 4 mm thickness (30 kV-50 µA).



Figure S17 RL spectra of CsPbBr<sub>3</sub> QDs/PPO LSS with 2 mm and 4 mm thickness (60 kV-50  $\mu$ A and 70 kV-50  $\mu$ A).



Figure S18 RL spectra of CsPbBr<sub>3</sub> QDs/PPO LSS with 4 mm and 1 cm thickness (80 kV-50  $\mu$ A and 90 kV-50  $\mu$ A).



Figure S19 Schematic diagram of the energy resolved X-ray detector based on the LSS.

Voltage-	20 kV-	20 kV-	20 kV- 30	20 kV- 40	20 kV- 50	20 kV- 60	20 kV- 70	20 kV- 80	20 kV- 90	20 kV-
current	10 μΑ	20 µА	μΑ	100 μΑ						
Dose rate <b>(</b> µGy/s)	15.25	29.72	44.17	58.61	73.33	88.89	102.78	119.44	130.56	144.63

Table S1 Measured dose rate as the function of tube voltage and current.

Scintillator	Light yield (Photons/keV)	
CsI(TI) : Commercial Solid	54.0	473%
Nal(TI) : Commercial Solid	38.0	330%
Standard LS : PPO+POPOP+toluene	11.4	100%
Hybrid LS : CsPbBr <sub>3</sub> (60 mg/ml)+PPO (30 mg/ml)	9.6	84%
Hybrid LS : CsPbBr <sub>3</sub> (60 mg/ml)+PPO (60 mg/ml)	10.6	93%
CsPbBr <sub>3</sub> (60mg/ml)	3.0	27%

**Table S2**. Comparison of the light yield of various solid and liquid scintillators. The light yield of the standard PPO+POPOP+toluene is known, then the light yield values of other liquid scintillators were evaluated versus to that of the standard PPO+POPOP +toluene scintillator. The efficiency of the commercial CsI and NaI solid scintillator were obtained from Ref. (Tsipenyuk, Y. M. Physical methods, instruments and measurements, Volume II, p. 71).